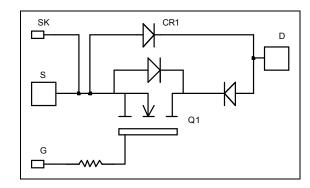


# Single switch Series & parallel diodes MOSFET Power Module

$$\begin{split} V_{DSS} &= 1000 V \\ R_{DSon} &= 65 m \Omega \text{ typ @ Tj} = 25^{\circ} C \\ I_D &= 145 A \text{ @ Tc} = 25^{\circ} C \end{split}$$



### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### **Features**

- Power MOS 7<sup>®</sup> MOSFETs
  - Low R<sub>DSon</sub>
  - Low input and Miller capacitance
  - Low gate charge
  - Avalanche energy rated
  - Very rugged
- Kelvin source for easy drive
- Very low stray inductance
  - Symmetrical design
  - M5 power connectors
- High level of integration
- AlN substrate for improved thermal performance



- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile
- RoHS Compliant

### All ratings @ $T_j = 25$ °C unless otherwise specified

#### **Absolute maximum ratings**

Symbol	Parameter		Max ratings	Unit	
$V_{ m DSS}$	Drain - Source Breakdown Voltage		1000	V	
Ţ	Continue Davis Comme	$T_c = 25^{\circ}C$	145		
$1_{\mathrm{D}}$	$I_D$ Continuous Drain Current $T_c$		110	A	
$I_{DM}$	Pulsed Drain current		580		
$V_{GS}$	Gate - Source Voltage		±30	V	
$R_{DSon}$	Drain - Source ON Resistance		78	mΩ	
$P_D$	Maximum Power Dissipation $T_c = 25^{\circ}C$		3250	W	
$I_{AR}$	Avalanche current (repetitive and non repetitive)		30	A	
$E_{AR}$	Repetitive Avalanche Energy		50	mJ	
$E_{AS}$	Single Pulse Avalanche Energy	•	3200	1113	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 1000V$			400	μA
R <sub>DS(on)</sub>	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 72.5A$		65	78	$m\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 20$ mA	3		5	V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$			±400	nA

**Dynamic Characteristics** 

•	Characteristic Characteristic	Test Conditions	Min	Тур	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$		28.5		
$C_{oss}$	Output Capacitance	$V_{\rm DS} = 25 V$		5.08		nF
$C_{rss}$	Reverse Transfer Capacitance	f = 1MHz		0.9		
$Q_{\mathrm{g}}$	Total gate Charge	$V_{GS} = 10V$		1068		
$Q_{gs}$	Gate – Source Charge	$V_{\text{Bus}} = 500V$		136		nC
$Q_{\mathrm{gd}}$	Gate – Drain Charge	$I_D = 145A$		692		
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = 15V$		18		
$T_{r}$	Rise Time	$V_{\text{Bus}} = 500 \text{V}$		14		ns
T <sub>d(off)</sub>	Turn-off Delay Time	$I_D = 145A$		140		
$T_{\mathrm{f}}$	Fall Time	$R_G = 0.75\Omega$		55		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C		4.8		I
$E_{\text{off}}$	Turn-off Switching Energy	$V_{GS} = 15V, V_{Bus} = 670V$ $I_D = 145A, R_G = 0.75\Omega$		2.9		mJ
$E_{on}$	Turn-on Switching Energy	Inductive switching @ 125°C $V_{GS} = 15V$ , $V_{Bus} = 670V$ $I_D = 145A$ , $R_G = 0.75\Omega$		8		I
$E_{\text{off}}$	Turn-off Switching Energy			3.9		mJ
$R_{\text{thJC}}$	Junction to Case Thermal Resistance				0.038	°C/W

### Series diode ratings and characteristics

Symbol	Characteristic 2	Test Conditions		Min	Тур	Max	Unit
$V_{RRM}$	Maximum Peak Repetitive Reverse Vol	tage	nge				V
$I_{RM}$	Maximum Reverse Leakage Current	V <sub>R</sub> =1000V				750	μΑ
$I_F$	DC Forward Current		$Tc = 80^{\circ}C$		240		A
		$I_{\rm F} = 240 A$			2	2.5	
$V_{\mathrm{F}}$	Diode Forward Voltage	$I_F = 480A$			2.2		V
		$I_F = 240A$	$T_j = 125$ °C		1.7		
4	Reverse Recovery Time	$T_j = 25^\circ$			280		
$t_{rr}$		$I_F = 240A$	$T_j = 125$ °C		350		ns
Q <sub>rr</sub>	Reverse Recovery Charge	$V_{R} = 667V$ $di/dt = 800A/\mu s$	$T_j = 25$ °C		3.04		C
			$T_{\rm j} = 125^{\circ}{\rm C}$		14.4		μC
$R_{\text{thJC}}$	Junction to Case Thermal Resistance					0.23	°C/W

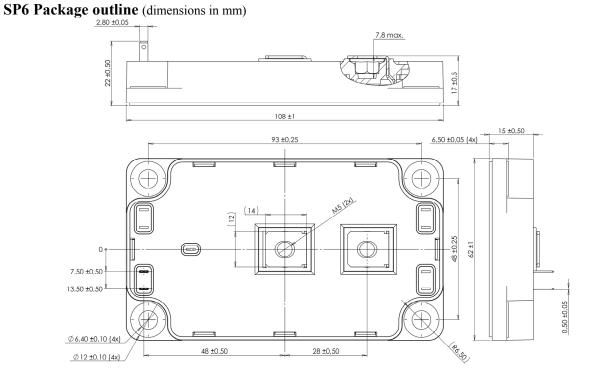


### Parallel diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$V_{RRM}$	Maximum Peak Repetitive Reverse Vol	tage	age				V
$I_{RM}$	Maximum Reverse Leakage Current	V <sub>R</sub> =1000V				750	μΑ
$I_F$	DC Forward Current		$Tc = 80^{\circ}C$		240		A
		$I_F = 240A$			2	2.5	
$V_{\mathrm{F}}$	Diode Forward Voltage	$I_F = 480A$			2.2		V
		$I_F = 240A$	$T_j = 125$ °C		1.7		
	$t_{rr}$ Reverse Recovery Time $I_F = 240 A$		$T_j = 25^{\circ}C$		280		
$\iota_{rr}$		$I_F = 240A$	$T_{j} = 125^{\circ}C$		350		ns
0	Danier Danier Change	$V_R = 667V$ $di/dt = 800A/\mu s$	$T_j = 25$ °C		3.04		C
$Q_{rr}$	Reverse Recovery Charge		$T_{j} = 125^{\circ}C$		14.4		μC
$R_{thJC}$	Junction to Case Thermal Resistance					0.23	°C/W

Thermal and package characteristics

Symbol	Characteristic			Min	Max	Unit			
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000		V			
$T_{J}$	Operating junction temperature range		-40	150					
$T_{JOP}$	Recommended junction temperature	nditions	-40	T <sub>J</sub> max -25	-25 °C				
$T_{STG}$	Storage Temperature Range -40 125								
$T_{\rm C}$	Operating Case Temperature			-40	0 100				
Torque	Mounting torque	To Heatsink	M6	3	5	N.m			
Torque	Mounting torque For teminals M5			2	3.5	IN.III			
Wt	Package Weight				300	g			

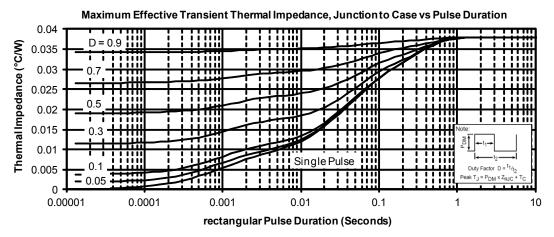


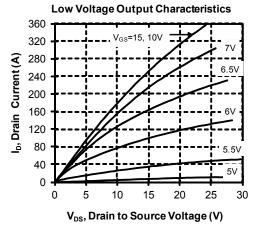
See application note APT0601 - Mounting Instructions for SP6 Power Modules on www.microsemi.com

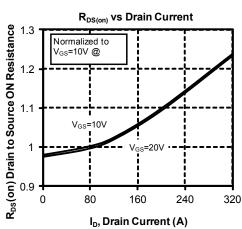
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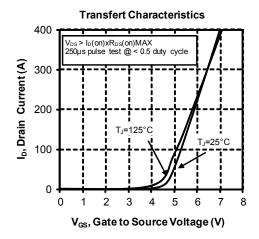


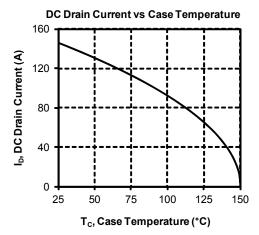
### **Typical Performance Curve**



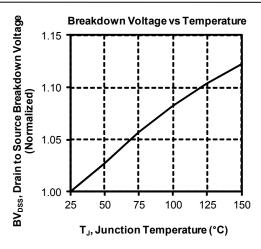


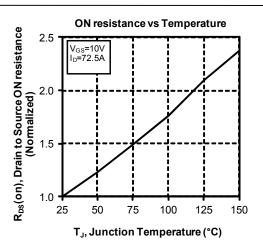


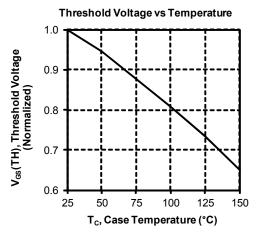


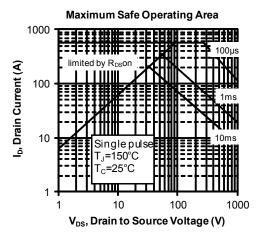


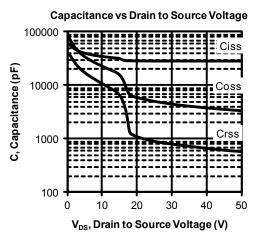


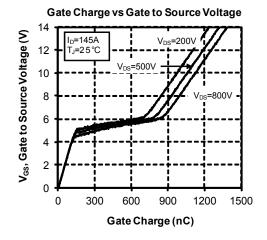




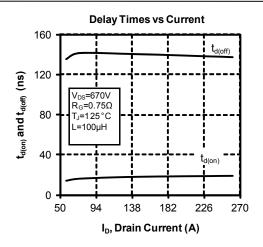


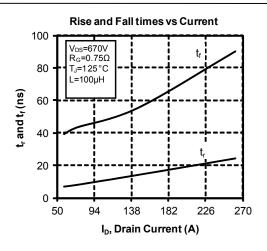


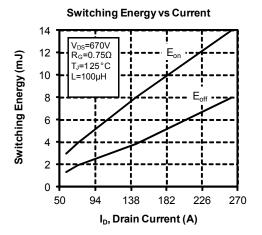


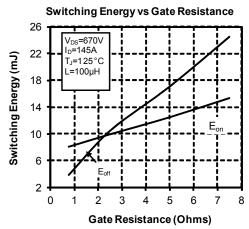


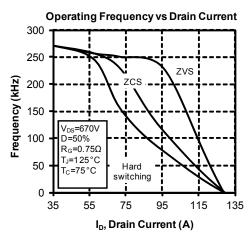












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